



LIGITEK

LIGITEK ELECTRONICS CO.,LTD.

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DOT MATRIX DIGIT LED DISPLAY (1.2Inch)



Lead-Free Parts

LMD8811/2AHRF-XX-PF

DATA SHEET

DOC. NO : QW0905-LMD8811/2AHRF-XX-PF

REV. : A

DATE : 15 - Feb. - 2007



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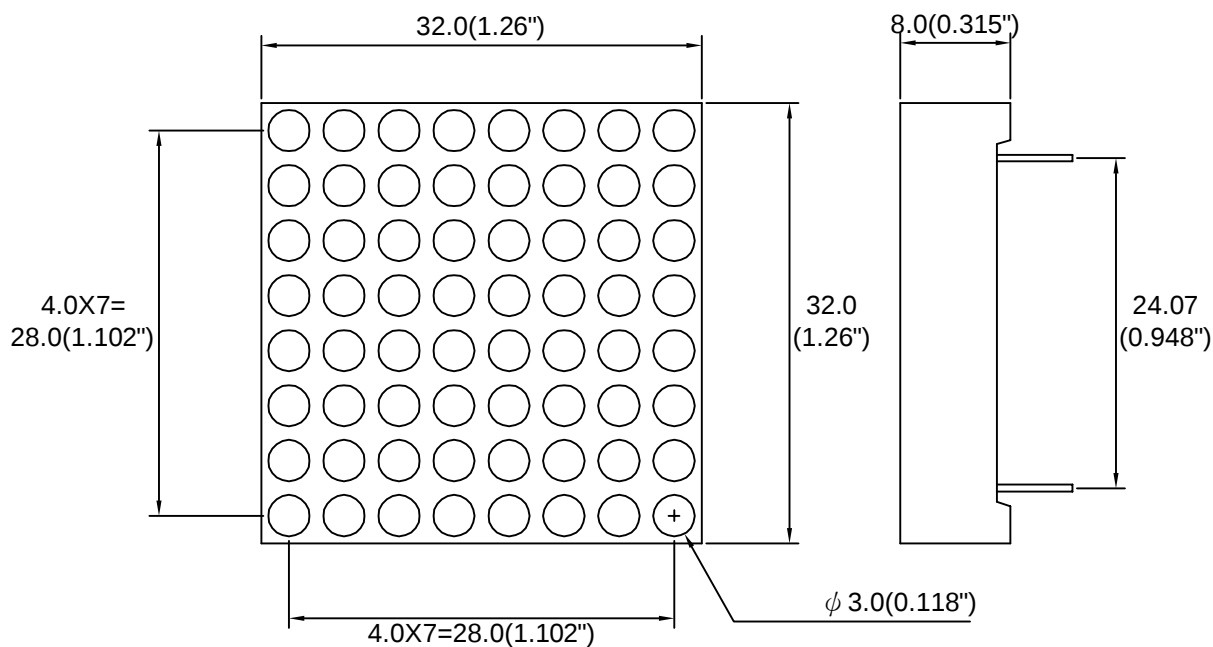
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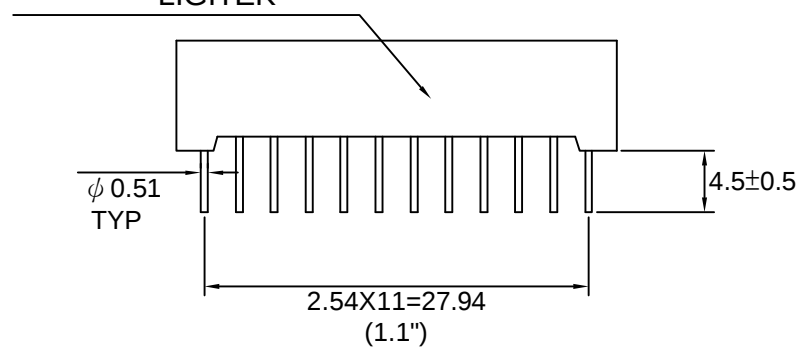
PART NO. LMD8811/2AHRF-XX-PF

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Package Dimensions



LMD8811/2AHRF-XX-PF
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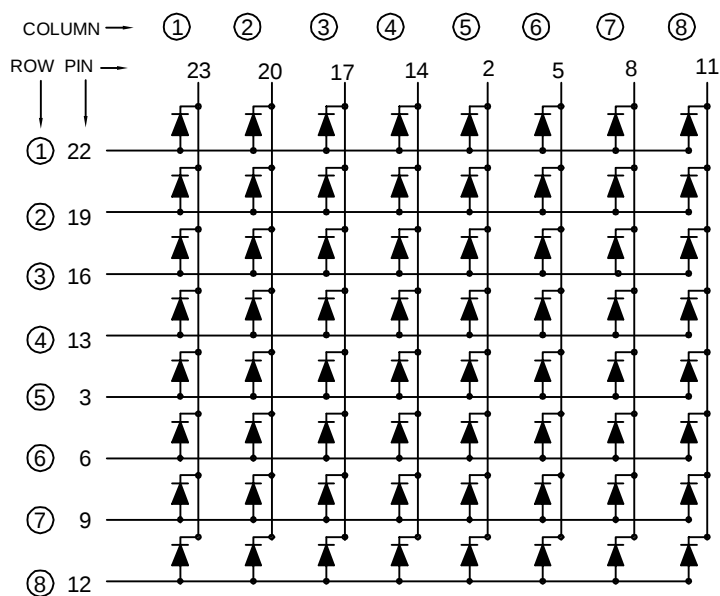
PIN NO.1 →

Note : 1.All dimension are in millimeters and (Inch) tolerance is $\pm 0.25\text{mm}$ unless otherwise noted.
2.Specifications are subject to change without notice.

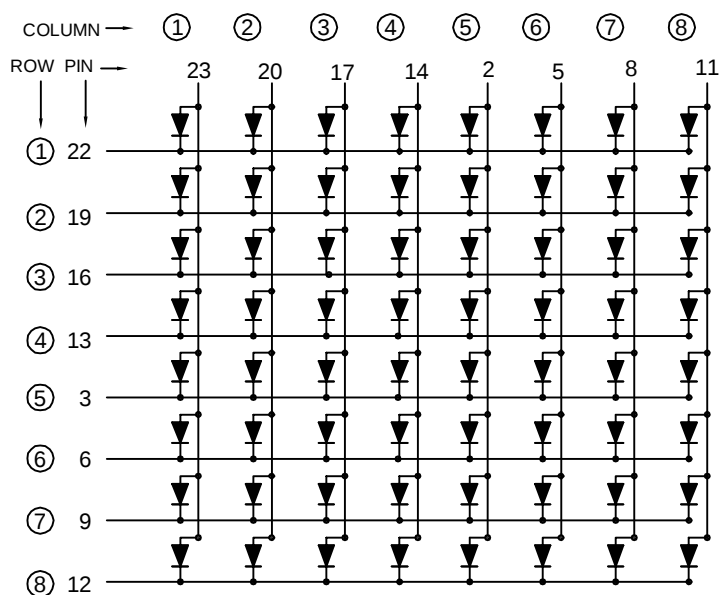


Internal Circuit Diagram

LMD8811AHRF-XX-PF



LMD8812AHRF-XX-PF



1,4,7,10,15,18,21,24PIN NC

**Electrical Connection**

PIN NO.	LMD8811AHRF-XX-PF	PIN NO.	LMD8811AHRF-XX-PF
1	NO CONNECT	13	Anode Row 4
2	Cathode Column 5 (Red)	14	Cathode Column 4 (Red)
3	Anode Row 5	15	NO CONNECT
4	NO CONNECT	16	Anode Row 3
5	Cathode Column 6 (Red)	17	Cathode Column 3 (Red)
6	Anode Row 6	18	NO CONNECT
7	NO CONNECT	19	Anode Row 2
8	Cathode Column 7 (Red)	20	Cathode Column 2 (Red)
9	Anode Row 7	21	NO CONNECT
10	NO CONNECT	22	Anode Row 1
11	Cathode Column 8 (Red)	23	Cathode Column 1 (Red)
12	Anode Row 8	24	NO CONNECT



Electrical Connection

PIN NO.	LMD8812AHRF-XX-PF	PIN NO.	LMD8812AHRF-XX-PF
1	NO CONNECT	13	Cathode Row 4
2	Anode Column 5 (Red)	14	Anode Column 4 (Red)
3	Cathode Row 5	15	NO CONNECT
4	NO CONNECT	16	Cathode Row 3
5	Anode Column 6 (Red)	17	Anode Column 3 (Red)
6	Cathode Row 6	18	NO CONNECT
7	NO CONNECT	19	Cathode Row 2
8	Anode Column 7 (Red)	20	Anode Column 2 (Red)
9	Cathode Row 7	21	NO CONNECT
10	NO CONNECT	22	Cathode Row 1
11	Anode Column 8 (Red)	23	Anode Column 1 (Red)
12	Cathode Row 8	24	NO CONNECT



Absolute Maximum Ratings at Ta=25 °C

Parameter	Symbol	Ratings	UNIT
		HRF	
Forward Current	I _F	30	mA
Peak Forward Current Duty 1/10@10KHz	I _{FP}	90	mA
Power Dissipation	PD	75	mW
Reverse Current @5V	I _r	10	μA
Electrostatic Discharge(*)	ESD	2000	V
Operating Temperature	T _{opr}	-25 ~ +85	°C
Storage Temperature	T _{stg}	-25 ~ +85	°C
Solder Temperature 1/16 Inch Below Seating Plane For 3 Seconds At 260 °C			

★ Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrostatic glove is recommended when handling these LED. All devices, equipment and machinery must be properly grounded.

Part Selection And Application Information(Ratings at 25°C)

PART NO	CHIP		common cathode or anode	λ D (nm)	$\Delta \lambda$ (nm)	Electrical					IV-M
	Material	Emitted				Vf(v)			Iv(mcd)		
						Min.	Typ.	Max.	Min.	Typ.	
LMD8811AHRF-XX-PF	AlGaInP	Red	Common Cathode	630	20	1.5	1.8	2.4	12.8	21.5	2:1
LMD8812AHRF-XX-PF	AlGaInP	Red	Common Anode	630	20	1.5	1.8	2.4	12.8	21.5	

Note : 1.The forward voltage data did not including ±0.1V testing tolerance.

2. The luminous intensity data did not including ±15% testing tolerance.

**Test Condition For Each Parameter**

Parameter	Symbol	Unit	Test Condition
Forward Voltage Per Chip	V _f	volt	I _f =20mA
Luminous Intensity Per Chip	I _v	mcd	I _f =10mA
Dominant Wavelength	λ D	nm	I _f =20mA
Spectral Line Half-Width	$\Delta \lambda$	nm	I _f =20mA
Reverse Current Any Chip	I _r	μ A	V _r =5V
Luminous Intensity Matching Ratio	IV-M		



Typical Electro-Optical Characteristics Curve

HRF CHIP

Fig.1 Forward current vs. Forward Voltage

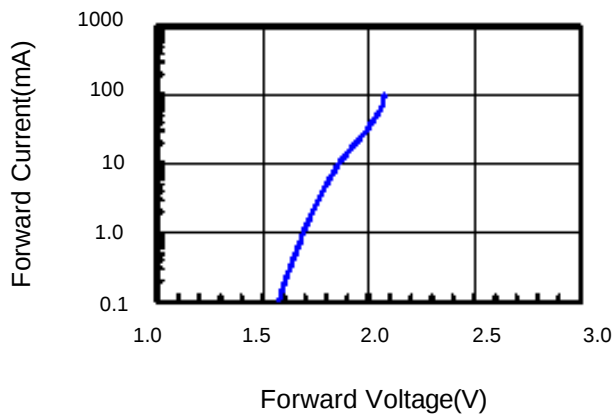


Fig.2 Relative Intensity vs. Forward Current

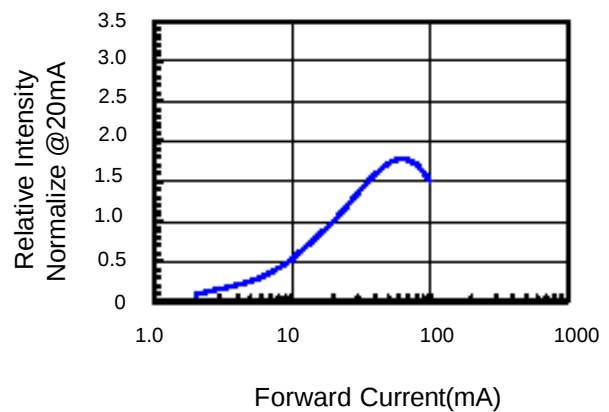


Fig.3 Forward Voltage vs. Temperature

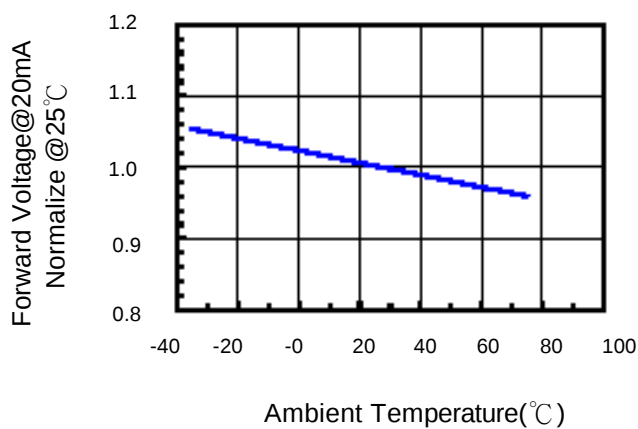


Fig.4 Relative Intensity vs. Temperature

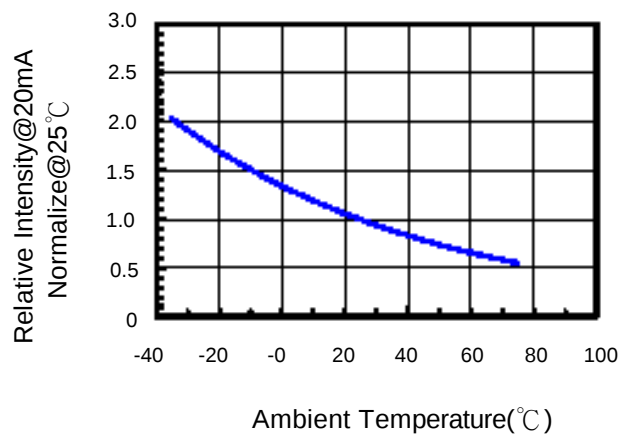
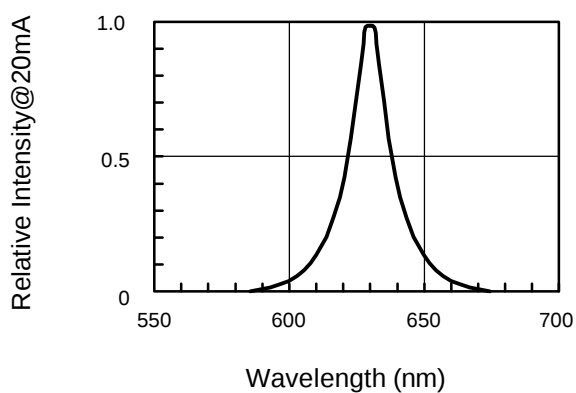


Fig.5 Relative Intensity vs. Wavelength



**Soldering Condition(Pb-Free)****1.Iron:**

Soldering Iron:30W Max

Temperature 350 °C Max

Soldering Time:3 Seconds Max(One time only)

Distance:Solder Temperature 1/16 Inch Below Seating
Plane For 3 Seconds At 260 °C**2.Wave Soldering Profile**

Dip Soldering

Preheat: 120°C Max

Preheat time: 60seconds Max

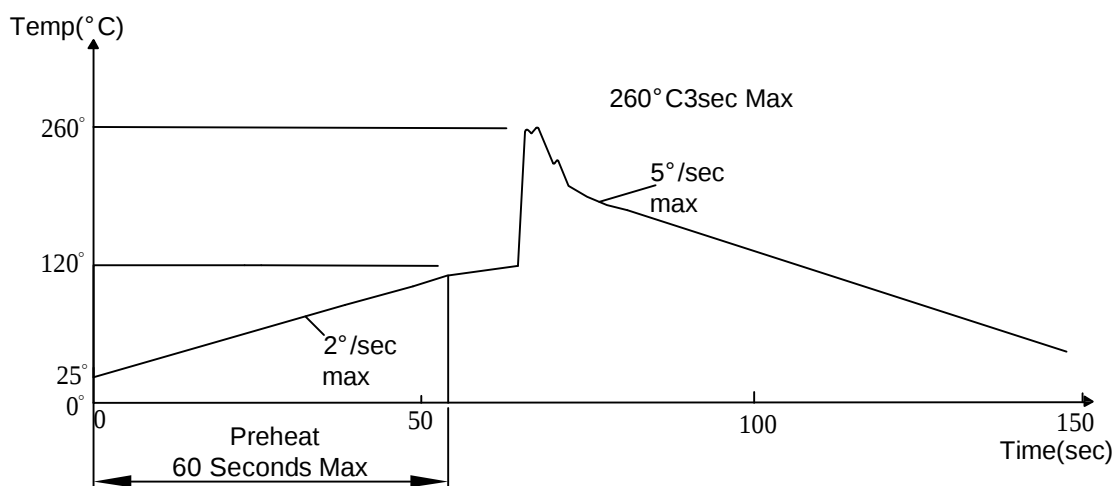
Ramp-up

2°/sec(max)

Ramp-Down:-5°/sec(max)

Solder Bath:260°C Max

Dipping Time:3 seconds Max

Distance:Solder Temperature 1/16 Inch Below Seating
Plane For 3 Seconds At 260°C

Note: 1.Wave solder should not be made more than one time.

2.You can just only select one of the soldering conditions as above.

**Reliability Test:**

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=10mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 °C ±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 °C ±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 °C ±5°C 2.RH=90 %~95% 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 °C ±5°C & -40°C ±5°C (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 °C ±5°C 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 °C ±5°C 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2